

Application No.	Applicant(s)	
09/772,986	HAYASHI ET AL.	
Examiner	Art Unit	
Thien F Tran	2811	

	SEARCHED			
Class	Subclass	Date	Examiner	
257	59	2/24/2004	тт	
257	64-66	2/24/2004	TT	
257	70	2/24/2004	TT	
257	72	2/24/2004	TT	
257	75	2/24/2004	TT	
257	347	2/24/2004	TT	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEA	I NOTES RCH STRATEG)	<b>(</b> )
	DATE	EXMR
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